


<b>Search Notes</b>  	<b>Application/Control No.</b>  10564653	<b>Applicant(s)/Patent Under Reexamination</b>  HAN ET AL.
	<b>Examiner</b>  MEGHAN FINN	<b>Art Unit</b>  1614

SEARCHED			
Class	Subclass	Date	Examiner
514	183	3/10/08	MF

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Names Search	3/10/08	MF
EAST Search (see attached notes)	3/10/08	MF
STN Search (see attached notes)	3/10/08	MF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner